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	10/750,845	01/05/2004	Sung-Chul Kang	YOM-0205	3873
	23413 CANTOR COL	7590 04/17/200 LBURN, LLP		EXAMINER	
55 GRIFFIN ROAD SOUTH BLOOMFIELD, CT 06002	55 GRIFFIN R	OAD SOUTH		CHU, JOHN S Y	
		ART UNIT	PAPER NUMBER		
				1752	
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	SHORTENED STATUTOR	Y PERIOD OF RESPONSE	MAIL DATE	DELIVERY MODE	
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	Application No.	Applicant(s)	
Office Action Commence	10/750,845	KANG ET AL.	
Office Action Summary	Examiner	Art Unit	
	John S. Chu	1752	
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the	correspondence address	
 WHICHEVER IS LONGER, FROM THE MAILING DA Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. If NO period for reply is specified above, the maximum statutory period w Failure to reply within the set or extended period for reply will, by statute, 	the Action Summary 10/750,845		
Status			
2a) ☐ This action is FINAL . 2b) ☑ This 3) ☐ Since this application is in condition for allowar	action is non-final. nce except for formal matters, p		
Disposition of Claims			
5)⊠ Claim(s) <u>21</u> is/are allowed. 6)⊠ Claim(s) <u>11-14 and 16-20</u> is/are rejected. 7)□ Claim(s) is/are objected to.	vn from consideration.		
Application Papers			
Applicant may not request that any objection to the o	epted or b) objected to by the drawing(s) be held in abeyance. So ion is required if the drawing(s) is o	ee 37 CFR 1.85(a). bjected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119			
 a) All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the prior application from the International Bureau 	s have been received. s have been received in Applica ity documents have been receiv (PCT Rule 17.2(a)).	tion No red in this National Stage	
Attachment(s)			
Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO/SB/08)		Date	

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DETAILED ACTION

This Office action is in response to the RCE filed September 27, 2006.

Claim Rejections - 35 USC § 112

- 1. The following is a quotation of the second paragraph of 35 U.S.C. 112:
 - The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.
- 2. Claims 11-14, and 16-20 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

The claims to the method lack recited method steps so in essence it is a recited method in the preamble with an intended use to apply the composition to a substrate. The claim is indefinite without any active, positive steps delimiting how this use is actually practiced.

Correction is necessary.

Claim Rejections - 35 USC § 103

- 3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 4. Claims 11-14 and 16-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over JEFFRIES, III et al (5,346,799) or EBERSOLE (5,324,620) in view of KODAMA et al (5,853,949) SHERIFF et al (6,117,610) and GRACIA et al (6,232,031 B1).

The claimed invention has been recited hereafter:

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11. (Currently Amended) A method for applying a photoresist composition to a large-scale substrate by an MMN head coater, wherein the photoresist composition comprises:

- (a) 5 wt% to 30 wt% of a polymer resin represented by the following Chemical Formula 1;
 - (b) 2 wt% to 10 wt% of a diazide photoactive compound;
 - (c) 50 wt% to 90 wt% of an organic solvent; and
 - (d) 500 to 4000 ppm of a Si based surfactant:

Chemical Formula 1

wherein R is C₁ to C₄ alkyl, and n is an integer of 15 to 10,000, and wherein the Si-based surfactant is a polyoxyalkylene dimethylpolysiloxane copolymer compound.

wherein the composition and content of solvent and aurfactant is controlled to prevent stains and improve conting characteristics in a photoresist film formed on the substrate from the photoresist composition, and

wherein stains include central stains, lateral stains, or cloudy stains.

and is included by reference wherein claim 6 is further drawn to the addition of a crosslinking agent is shown below:

16. (withdrawn) The method of Claim 11,

wherein the composition further comprises one or more nitrogen-containing crosslinking agents selected from the group consisting of a condensation product of urea and formaldehyde, a condensation product of melamine and formaldehyde, a methylol urea alkylether, and a methylol melamine alkylether.

Each of JEFFRIES, III et al, or EBERSOLE recite a photoresist composition comprising a S-based surfactant in a composition comprising a novolak resin and a quinonediazide compound. Said references fail to teach the use of a crosslinking agent in the photoresist composition as currently recited in claim 6.

KODAMA et al '949 discloses a positive photoresist composition comprising a novolak resin and a quinonediazide compound with the addition of a polyphenol compound, see <u>column</u>

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6, lines 32 – column 7, line 60 for the alkali-soluble resin and photosensitive compound.

Applicants are directed to column 11, lines 46-51 wherein KODAMA et al teaches the use of surfactants being Si-based. In fact the same surfactants as disclosed in JEFFRIES, III et al and EBERSOLE are disclosed here in KODAMA et al, see the surfactant trade name of FLORAD FC-430 in column 11, line 46.

The primary disclosure which the examiner relies on is found in column 12, lines 40-56 wherein KODAMA et al discloses the suitable use of crosslinking agents which serve to improve the dry etching resistance, improve sensitivity and heat resistance, yet not alter the positive working property of the photoresist composition. Specific crosslinking agents include melamine-formaldehyde and others like benzoguanamine and glycouril-formaldehyde. Thus the skilled artisan is motivated to use such components to improve the photoresist image that is formed.

Each of SHERIFF et al and GRACIA et al are cited of interest with respect to the use of polyether modified dimethylpolysiloxane copolymer surfactants. The <u>Examples 3-6</u> in SHERIFF et al disclose the following attached:

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EXAMPLES 3-6

Four imaging compositions and plates of the present invention were prepared using the following components:

COMPONENT	Example 3 (grams)	Example 4 (grams)	Example 5 (grams)	Example 6 (grams)
Cresol-formaldehyde novolac resin	4.620	4.620	4.620	4.620
2,4 Bis(2-diazo-1,2-dihydro-1-oxo-5-naphthalenesulfonyloxy) benzo-phenone	1.154	1.154	1.154	1.154
Carbon black	0.108	0.217	0.434	0.868
1-Methoxy-2-propanol solvent	88.118	88.009	87.792	87.358
Acetone	5.881	5.881	5.881	5.881
CG-21-1005	0.108	0.108	0.108	0.108
BYK-307	0.011	0.011	0.011	0.011

CG 21-1005 is a dye available from Ciba-Geigy.

BYK-307 is a polyether-modified polydimethylsiloxane available from BYK-Chemie.

wherein BYK-307 is a surfactant as claimed in claim 11.

GRACIA et al likewise discloses the use of BYK 344 surfactant in Examples 1-4 in a composition with a quinone diazide compound and a novolak resin. Here the use of a polyoxyalkylene dimethylpolysiloxane copolymer surfactant is taught in a composition for photolithographic compositions comprising a diazide compound a phenol novolak resin and a solvent. BYK 333 and BYK 344 are attached with their product descriptions from the BYK-Chemie product list.

It would have been *prima facie* obvious to one of ordinary skill in the art of positive photoresist compositions to add a crosslinking agent, such as melamine-formaldehyde into the photoresist composition of JEFFRIES, III et al or EBERSOLE as an agent to improve dry etching resistance, and heat resistance and reasonably expect same or similar results as disclosed

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in JEFFRIES, III et al or EBERSOLE for high thermal resistance and low scumming upon development.

It also would have been prima facie obvious to one of ordinary skill in the art of photolithographic compositions and coating methods to add the known surfactants as disclosed in SHERIFF et al and GRACIA et al into the compositions of JEFFRIES, III et al. EBERSOLE and reasonably expect same or similar results with respect to having compositions with high thermal resistance.

The argument by applicant have been carefully considered, however it is believed that a prima facie case of obviousness is present wherein each of the components are disclosed to be known and one of ordinary skill in the art would be directed to use the crosslinking agent and the surfactants as disclosed above. The examiner notes that method claim of claim 11 is indefinite as a method wherein the steps are lacking, thus the claim is seen as an intended use claim of a known or obvious composition. The rejection is repeated.

. 5. Claim 21 is allowed.

The recited method claim in claim 21 is seen as a proper method wherein the composition is processed by applying to a substrate with the MMN head coater by spray-dispense coating and spinning.

The coating process using the MMN head coater is not disclosed in any of the prior art references of record and the claim is seen as allowable over the prior art of record.

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6. The prior art made of record and not relied upon is considered pertinent to applicant's

disclosure. DARAKTCHIEV is cited to disclose a process for coating a photoresist composition

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by atomized spray coating.

7. Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Examiner Chu whose telephone number is (571) 272-1329. The

examiner can normally be reached on Monday - Friday from 9:30 am to 6:00 pm.

If attempts to reach the Examiner by telephone are unsuccessful, the Examiner's

supervisor, Cynthia Kelly, can be reached on (571) 272-1526

The fax phone number for the USPTO is (571) 273-8300.

Information regarding the status of an application may be obtained from the Patent

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system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

John S. Chu

Primary Examiner, Group 1700

J.Chu April 13, 2007